Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination OHNO ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,136,667	08-1992	Ohno et al.	356/460
*	В	US-5,245,407	09-1993	Nishiura et al.	356/460
*	С	US-5,854,678	12-1998	Liu et al.	356/462
*	D	US-6,175,410	01-2001	Szafraniec et al.	356/459
*	E	US-6,801,319	10-2004	Szafraniec et al.	356/460
*	F	US-6,990,269	01-2006	Ohno et al.	356/483
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	ال	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

	TOTAL POOR METERS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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